

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/726,746	SURNILLA ET AL.	
Examiner		Art Unit	Page 1 of 1	
Tu M. Nguyen		3748		

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,051,516	05-2006	Pott et al.	60/285
*	B	US-7,104,047	09-2006	Takubo, Hideki	60/285
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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